

<b>Notice of References Cited</b>	Application/Control No. 10/061,474	Applicant(s)/Patent Under Reexamination TEIG ET AL.	
	Examiner Belix M. Ortiz	Art Unit 2164	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,587,990	07-2003	Andreev et al.	716/2
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	M	US-			

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**NON-PATENT DOCUMENTS**

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